3rd International Summer School on INtelligent Signal Processing for FrontlEr Research and Industry



Contribution ID: 26 Type: not specified

Test systems in HEP: Lab-based test benches and test beams

Friday 25 September 2015 09:00 (1h 30m)

Presenter: Dr JANSEN, Hendrik (DESY)

Session Classification: New Test Bench and Demonstrators developed for Future Experiments/Projects

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